Se	arch	rch Notes		

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/736,336	KIM ET AL.	
	Examiner	Art Unit	
	Anh T. Mai	2832	

SEARCHED			
Class	Subclass	Date	Examiner
336	200,223 232 updated	2/3/2007	АМ
29	602.1 605	2/3/2007	АМ
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INTERFERENCE SEARCHED		
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search updated; search history printout	2/3/2007	АМ
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